

Appl. No. 09/629,245  
Amdt. dated 1/26/2004  
Reply to 11/10/2003 Office action

**Amendments to the Claims:**

This listing of claims will replace all prior versions, and listing, of claims in the application:

**Listing of Claims:**

Claim 1 (original):

A method for determining an orientation of an object, the method comprising:  
acquiring an intensity image of the object;  
generating at least a portion of a two-dimensional frequency response of the intensity image;  
representing the at least a portion of a two-dimensional frequency response within a frequency space, the at least a portion of a frequency response providing features arranged in a spatial-frequency pattern within the frequency space;  
and  
finding an orientation of the spatial-frequency pattern within the frequency space, thereby providing the orientation of the object.

Claim 2 (original):

The method of claim 1, wherein the intensity image is of a portion of the object.

Claim 3 (currently amended):

The method of claim 1, wherein generating further includes:  
generating the at least a portion of a two-dimensional frequency response of the intensity image by applying a frequency analysis tool to the intensity image.

Claim 4 (original):

The method of claim 3, wherein generating the at least a portion of a two-dimensional frequency response of the intensity image includes:  
generating at least a portion of a magnitude of a two-

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dimensional discrete Fourier transform of the intensity image to provide the at least a portion of a two-dimensional frequency response.

Claim 5 (original):

The method of claim 4, wherein the two-dimensional discrete Fourier transform includes a two-dimensional discrete fast Fourier transform.

Claim 6 (original):

The method of claim 3, wherein generating the at least a portion of a two-dimensional frequency response of the intensity image includes:

generating at least a portion of a two-dimensional discrete cosine-transform of the intensity image to provide the at least a portion of a two-dimensional frequency response.

Claim 7 (original):

The method of claim 3, wherein generating the at least a portion of a two-dimensional frequency response of the intensity image includes:

generating at least a portion of a two-dimensional discrete sine-transform of the intensity image to provide the at least a portion of a two-dimensional frequency response.

Claim 8 (original):

The method of claim 3, wherein generating the at least a portion of a two-dimensional frequency response of the intensity image includes:

generating at least a portion of a two-dimensional z-transform of the intensity image to provide the at least a portion of a two-dimensional frequency response.

Claim 9 (original):

The method of claim 1, wherein representing further includes:  
representing the at least a portion of a two-dimensional

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Claim 10 (currently amended):

frequency response as a logarithmically scaled frequency response within the frequency space.  
The method of claim 1, wherein the frequency space is a frequency image, and wherein representing the at least a portion of a two-dimensional frequency response further includes:

scaling the at least a portion of a two-dimensional frequency response using a scaling function so as to enhance high frequency responses within the at least a portion of the two-dimensional frequency response to provide a scaled frequency response; and  
mapping the scaled response by gray scale on the frequency image.

Claim 11 (original):

The method of claim 1, wherein finding further includes:  
applying an angle finding means to the frequency space to provide an angle of the spatial-frequency pattern.

Claim 12 (original):

The method of claim 1, wherein finding further includes:  
identifying the spatial-frequency pattern within the frequency space; and  
finding the orientation of the spatial-frequency pattern.

Claim 13 (currently amended):

The method of claim 1, wherein the ~~at least a portion of a two-dimensional frequency response provides features forming a plurality of spatial-frequency patterns within the frequency space, and wherein finding further includes:~~  
finding the orientation of the plurality of spatial-

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frequency patterns.

Claim 14 (currently amended):

The method of claim 1, wherein the ~~at least a portion of a two-dimensional frequency response provides features~~ forming a plurality of spatial-frequency patterns within the frequency space, and wherein finding further includes:

identifying one dominant spatial-frequency pattern from among the plurality of spatial-frequency patterns; and  
finding the orientation of the dominant spatial-frequency pattern.

Claim 15 (original):

The method of claim 14, wherein identifying further includes:

identifying as the dominant spatial-frequency pattern one spatial-frequency pattern of the plurality of spatial-frequency patterns that includes a greatest number of the features.

Claim 16 (currently amended):

The method of claim 1, wherein the orientation of the object is at a constant offset from the orientation of the spatial-frequency pattern.

Claim 17 (original):

The method of claim 16, wherein the constant offset substantially equals zero.

Claim 18 (currently amended):

The method of claim 16, wherein the orientation of the object is defined by an orientation angle of an object feature on the object.

Claim 19 (original):

The method of claim 1, wherein the spatial-frequency pattern includes a line, the line having a line angle, and wherein the orientation of the object is an object angle, the object angle having a constant offset from the line angle.

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- Claim 20 (original): The method of claim 19, wherein the object is a leaded object having leads, and wherein the orientation of the leaded object is defined by an orientation angle of one of the leads.
- Claim 21 (original): The method of claim 19, wherein the object angle substantially equals an orientation angle of a surface mount object from an axis of the intensity image.
- Claim 22 (original): The method of claim 1, further comprising: inputting the orientation of the object into a subsequent image processing algorithm.
- Claim 23 (currently amended): A method for determining an orientation of an object, the method comprising:  
acquiring an intensity image of the object;  
generating at least a portion of at least a two-dimensional frequency response of the intensity image, frequencies within the at least a portion of at least a two-dimensional frequency response forming a spatial-frequency pattern;  
and  
finding an orientation of the spatial-frequency pattern, thereby providing the orientation of the object.
- Claim 24 (currently amended): The method of claim 23, wherein generating further includes:  
representing the frequencies within the at least portion  
of at least a two-dimensional frequency response within a frequency space, features within the frequency space forming the spatial-frequency pattern.
- Claim 25 (currently amended): The method of claim 24, wherein the frequency space is a frequency image, and wherein representing the at least

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a portion of at least a two-dimensional frequency response further includes:  
scaling the at least a portion of at least a two-dimensional frequency response using a scaling function so as to enhance high frequency responses within the at least a portion of at least the two-dimensional frequency response to provide a scaled frequency response; and  
mapping the scaled frequency response by gray scale on the frequency image.

a  
Claim 26 (currently amended):

The method of claim 23, wherein generating further includes:

generating the at least a portion of at least a two-dimensional frequency response of the intensity image by applying a frequency analysis tool to the intensity image.

Claim 27 (original):

The method of claim 26, wherein generating the at least a portion of at least a two-dimensional frequency response of the intensity image includes:

generating at least a portion of a magnitude of at least a two-dimensional discrete Fourier transform of the intensity image to provide the at least a portion of at least a two-dimensional frequency response.

Claim 28 (original):

The method of claim 23, further comprising:  
acquiring a plurality of intensity images of the object at different depths within the object; and  
generating a three-dimensional image containing a three-dimensional intensity representation of the object using the plurality of intensity images of

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the object;  
wherein generating the at least a portion of at least a  
two-dimensional frequency response of the  
intensity image further includes:

generating at least a portion of a three-dimensional  
frequency response by applying a frequency  
analysis tool to the three-dimensional image.

a  
Claim 29 (currently amended):

The method of claim 243, wherein the orientation of the  
object in the intensity image is at a constant offset from  
the orientation of the spatial-frequency pattern in the  
frequency space.

Claim 30 (original):

The method of claim 29, wherein the orientation of the  
object is defined by an orientation angle of a feature on  
the object.

Claim 31 (original):

The method of claim 23, wherein the spatial-frequency  
pattern includes a line, the line having a line angle, and  
wherein the orientation of the object is an object angle,  
the object angle having a constant offset from the line  
angle.

Claim 32 (original):

An apparatus for determining an orientation of an  
object within an intensity image, the apparatus  
comprising:  
frequency means adapted to generate at least a portion  
of at least a two-dimensional frequency  
response of the intensity image;  
a frequency space adapted to receive the at least a  
portion of at least a two-dimensional frequency  
response, the at least a portion of a frequency  
response providing features arranged in a  
spatial-frequency pattern within the frequency


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space; and

finding means adapted to find an orientation of the spatial-frequency pattern within the frequency space, thereby providing the orientation of the object.

Claim 33 (currently amended):

The apparatus of claim 32, wherein the frequency means is further adapted to generate the at least a portion of at least a two-dimensional frequency response of the intensity image by applying a frequency analysis tool to the intensity image.

 Claim 34 (original):

The apparatus of claim 33, wherein the frequency means is further adapted to generate at least a portion of a magnitude of at least a two-dimensional discrete Fourier transform of the intensity image to provide the at least a portion of at least a two-dimensional frequency response.

Claim 35 (original):

The apparatus of claim 32, wherein the frequency space is a frequency image, the apparatus further comprising: scaling means, adapted to scale the at least a portion of at least a two-dimensional frequency response on the frequency space using a scaling function so as to enhance high frequency responses within the at least a portion of the two-dimensional frequency response and to provide a scaled frequency response; and mapping means, in cooperation with the scaling means, adapted to map the scaled frequency response by grey scale on the frequency image.

Claim 36 (original):

The apparatus of claim 32, wherein the orientation of the object in the intensity image is at a constant offset



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from the orientation of the spatial-frequency pattern in the frequency space.

Claim 37 (original):

The apparatus of claim 36, wherein the orientation of the object is defined by an orientation angle of a feature on the object.

Claim 38 (original):

The apparatus of claim 32, wherein the spatial-frequency pattern includes a line, the line having a line angle, and wherein the orientation of the object is an object angle, the object angle having a constant offset from the line angle.

Claim 39 (original):

A method for finding an orientation of an object, the method comprising:

acquiring an intensity image of the object;

applying a frequency analysis tool to the intensity

image to produce at least a portion of a two-dimensional frequency response of the intensity image;

representing the at least a portion of a two-dimensional

frequency response within a frequency space,

the at least a portion of a frequency response

providing features arranged in spatial-frequency

pattern within the frequency space; and

determining an orientation of the spatial-frequency

pattern to provide the orientation of the object.

Claim 40 (original):

The method of claim 39, wherein applying the frequency analysis tool includes:

generating at least a portion of a magnitude of a two-

dimensional discrete Fourier transform of the

intensity image to provide the at least a portion

of a two-dimensional frequency response.

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Claim 41 (currently amended): The method of claim 39, wherein the frequency space is a frequency image, and wherein representing the at least a portion of a two-dimensional frequency response further includes:

scaling the at least a portion of a two-dimensional frequency response using a scaling function so as to enhance high frequency responses within the at least a portion of the two-dimensional frequency response to provide a scaled frequency response; and  
mapping the scaled response by gray scale on the frequency image.

Claim 42 (original):

The method of claim 39, wherein the orientation of the object in the intensity image is at a constant offset from the orientation of the spatial-frequency pattern in the frequency space.

Claim 43 (original):

The method of claim 42, wherein the orientation of the object is defined by an orientation angle of a feature on the object.

Claim 44 (original):

The method of claim 39, wherein the spatial-frequency pattern includes a line, the line having a line angle, and wherein the orientation of the object is an object angle, the object angle having a constant offset from the line angle.

Claim 45 (new):

The method of claim 1, wherein finding the orientation of the spatial-frequency pattern further includes:  
processing the frequency space as a second image to find the orientation of the spatial-frequency pattern therein.

Claim 46 (new):

The method of claim 1, wherein representing the at

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least a portion of a two-dimensional frequency response further includes:

interpreting the features of the at least a portion of a two-dimensional frequency response within the frequency space as image features in a second intensity image.

Claim 47 (new):

The method of claim 1, wherein finding the orientation of the spatial-frequency pattern further includes: conducting a pattern analysis on the features.

Claim 48 (new):

The method of claim 1, wherein the features in the frequency space are formed from uv data and finding the orientation further includes: interpreting the uv data as a second intensity image to find the orientation of the spatial-frequency pattern therein.

Claim 49 (new):

The method of claim 23, wherein finding the orientation further includes: representing the spatial-frequency pattern in a frequency space; and processing the frequency space as a second intensity image to find the orientation of the spatial-frequency pattern therein.

Claim 50 (new):

The apparatus of claim 32, wherein the finding means is further adapted to processes the frequency space as a second intensity image to find the orientation of the spatial-frequency pattern.

Claim 51 (new):

The apparatus of claim 32, wherein the features within the frequency space are image features of a second intensity image.

Claim 52 (new):

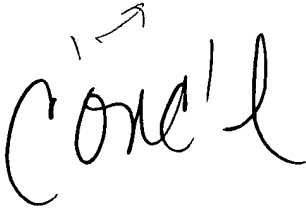
The apparatus of claim 32, wherein the finding means is

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Claim 53 (new):



Claim 54 (new):



further adapted to conduct a pattern analysis on the features.

The method of claim 39, wherein representing the at least a portion of a two-dimensional frequency response further includes:

interpreting the features of the at least a portion of a two-dimensional frequency response within the frequency space as image features in a second intensity image.

The method of claim 39, wherein determining the orientation of the spatial-frequency pattern further includes:

conducting a pattern analysis on the features.